

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

David Abraham, et al.

Serial No.:

10/680,260

Group Art Unit: 2814

Filing Date: October 8, 2003

Examiner:

Ahn D. Mai

For:

METHOD AND SYSTEM FOR PATTERNING OF MAGNETIC THIN FILMS

USING CHEMICAL TRANSFORMATION

Honorable Commissioner of Patents Alexandria, Virginia 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

Under the provisions of 37 CFR §1.97 through §1.98 and pursuant to applicants' duty of disclosure under 37 CFR §1.56, applicants respectfully bring the following document listed on the attached form PTO-1449, to the attention of the Examiner in charge of the above-identified application. A copy of the listed document is provided herewith for the convenience of the Examiner.

This citation does not constitute an admission that the reference is relevant or material to the claims. It is only cited as constituting related art of which applicants are aware.

I hereby certify that no item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing the certification after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in § 1.56(c) more than three months prior to the filing of the information disclosure statement.

It is respectfully requested that the listed reference be considered by the Examiner and formally made of record in this application.

Serial No. 10/680,260 Docket No. YOR920030013US1 YOR.427

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's Deposit Account No. 50-0510.

Date: June 26, 2006

MCGINN INTELLECTUAL PROPERTY LAW GROUP, PLLC

8321 Old Courthouse Road, Suite 200 Vienna, Virginia 22182-3817 (703) 761-4100 Customer No. 48150 Respectfully submitted,

Scott M. Tulino, Esq. Registration No. 48,317 Sean M. McGinn, Esq. Registration No. 34,386

JUN 2 6-2006 B		Sheet <u>1</u> of 1		
	ATTY. DOCKET NO.	SERIAL NO.		
FORM PTO-1449 PATENT AND TRADEMARK OFFICE	YOR920030013US1	10/680,260		
	APPLICANT			
LIST OF REFERENCES CITED BY APPLICANT	David Abraham, et al.			
(Use several sheets if necessary)	FILING DATE	GROUP		
	October 8, 2003	2814		

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
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FOREIGN PATENT DOCUMENTS

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

O I M Data No. 1 A			
	AL	"Patterning Magnetic Films by Ion Beam Irradation", J. Appl. Phys., Vol. 87, No. 9, 7004 (2000).	
	AM		
	AN		
EXAMINER		DATE CONSIDERED	

*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.